



SLLS984D – JUNE 2009 – REVISED JULY 2010

# Low-Power Dual Digital Isolators

Check for Samples: ISO7420, ISO7420M, ISO7421, ISO7421M

## FEATURES

- Highest Signaling Rate: 1 Mbps
- Low Power Consumption, Typical I<sub>CC</sub> per Channel (3.3V operation):
  - ISO7420: 1.1 mA, ISO7421: 1.5 mA
- Low Propagation Delay 9 ns Typ. and Low Skew – 300 ps Typ.
- Wide T<sub>A</sub> Range Specified: -40°C to 125°C
- 4-kVpeak Maximum Isolation, 2.5 kVrms per UL 1577, IEC/VDE and CSA Approvals, IEC 60950-1, IEC 61010-1 End Equipment Standards Approvals. All Approvals Pending.
- 50 kV/µs Transient Immunity, Typical
- Over 25-Year Isolation Integrity at Rated Voltage
- Operates From 3.3V and 5V Supply and Logic Levels

## APPLICATIONS

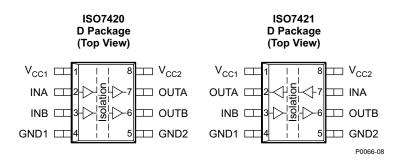
- Optocoupler Replacement in:
  - Industrial Fieldbus
    - Profibus
    - Modbus
    - DeviceNet<sup>™</sup> Data Buses
  - Servo Control Interface
  - Motor Control
  - Power Supplies
  - Battery Packs

## DESCRIPTION

The ISO7420, ISO7420M, ISO7421, and ISO7421M provide galvanic isolation up to 2.5 kVrms for 1 minute per UL. These digital isolators have two isolated channels. Each isolation channel has a logic input and output buffer separated by a silicon dioxide (SiO<sub>2</sub>) insulation barrier. Used in conjunction with isolated power supplies, these devices prevent noise currents on a data bus or other circuit from entering the local ground and interfering with or damaging sensitive circuitry. The suffix M indicates wide temperature range ( $-40^{\circ}$ C to  $125^{\circ}$ C).

The devices have TTL input thresholds and require two supply voltages, 3.3V or 5V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3V supply.

Note: The ISO7420 and ISO7421 are specified for signaling rates up to 1 Mbps. Due to their fast response time, under most cases, these devices will also transmit data with much shorter pulse widths. Designers should add external filtering to remove spurious signals with input pulse duration < 20ns if desired.



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## ISO7420, ISO7420M ISO7421, ISO7421M



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### **PIN FUNCTIONS**

|                  | PIN | 1/0   | DESCRIPTION                            |  |
|------------------|-----|-------|--|--|
| NAME             | NO. | - I/O | DESCRIPTION                            |  |
| INA              | 7   | I     | Input, channel A                       |  |
| INB              | 3   | I     | Input, channel B                       |  |
| GND1             | 4   | -     | Ground connection for V <sub>CC1</sub> |  |
| GND2             | 5   | -     | Ground connection for V <sub>CC2</sub> |  |
| OUTA             | 2   | 0     | Output, channel A                      |  |
| OUTB             | 6   | 0     | Output, channel B                      |  |
| V <sub>CC1</sub> | 1   | -     | Power supply, V <sub>CC1</sub>         |  |
| V <sub>CC2</sub> | 8   | -     | Power supply, V <sub>CC2</sub>         |  |

### Table 1. FUNCTION TABLE<sup>(1)</sup>

| INPUT SIDE<br>VCC | OUTPUT SIDE<br>VCC | INPUT<br>IN | OUTPUT<br>OUT    |
|-------------------|--------------------|-------------|------------------|
|                   |                    | Н           | Н                |
| PU                | PU                 | L           | L                |
|                   |                    | Open        | H <sup>(2)</sup> |
| PD                | PU                 | Х           | H <sup>(2)</sup> |

(1) PU = Powered up ( $V_{CC} \ge 3 V$ ); PD = Powered down ( $V_{CC} \le 2.4 V$ ); X = Irrelevant; H = High level; L = Low level

(2) In fail-safe condition, output is at high level for ISO7420, ISO7420M, ISO7421 and ISO7421M.

| PRODUCT               | RATED<br>ISOLATION       | PACKAGE | INPUT<br>THRESHOLD                | RATED T <sub>A</sub> | CHANNEL<br>DIRECTION                        | MARKED<br>AS | ORDERING<br>NUMBER   |  |        |
|-----------------------|--------------------------|---------|-----------------------------------|----------------------|---|--------------|----------------------|--|--------|
| ISO7420               |                          |         |                                   | –40°C to 105°C       |   | IS7420       | ISO7420D (rail)      |  |        |
| 1307420               |                          |         |                                   |                      |   | 137420       | ISO7420DR (reel)     |  |        |
|                       |                          |         |                                   |                      | Same direction                              | I7420M       | ISO7420MD (rail)     |  |        |
| ISO7420M              | $2 \in k \setminus rm c$ |         | ~1.5 V (TTL)<br>(CMOS compatible) | –40°C to 125°C       |   |              | ISO7420MDR<br>(reel) |  |        |
| ISO7421               | 2.5 kVrms                | D-8     |                                   | 10%C to 105%C        | 40°C to 105°C                               |              | /                    |  | 107404 |
| 1507421               |                          |         |                                   | –40°C to 105°C       | Onnasita                                    | IS7421       | ISO7421DR (reel)     |  |        |
| 100740414             |                          |         |                                   |                      | <ul> <li>Opposite<br/>directions</li> </ul> |              | ISO7421MD (rail)     |  |        |
| ISO7421M<br>(PREVIEW) |                          |         |                                   | –40°C to 125°C       |   | I7421M       | ISO7421MDR<br>(reel) |  |        |

#### **AVAILABLE OPTIONS**



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## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

|                     |  |   |  |          | VALUE          |  |
|---------------------|--|---|--|----------|----------------|--|
| V <sub>CC</sub>     | Supply voltage                                   | <sup>2)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub> |  |          | –0.5 V to 6 V  |  |
| VI                  | V <sub>I</sub> Voltage at IN, OUT                |   |  |          |                |  |
| lo                  | Output current                                   |   |  |          | ±15 mA         |  |
|                     |  | Human-body model                                    | JEDEC Standard 22, Test Method A114-C.01 |          | ±4 kV          |  |
| ESD                 | Electrostatic<br>discharge                       | Field-induced charged-device model                  | JEDEC Standard 22, Test Method C101      | All pins | ±1.5 kV        |  |
|                     |  | Machine model                                       | ANSI/ESDS5.2-1996                        |          | ±200 V         |  |
| T <sub>J(Max)</sub> | T <sub>J(Max)</sub> Maximum junction temperature |   |  |          |                |  |
| T <sub>stg</sub>    | Storage temper                                   | ature   |  |          | -65°C to 150°C |  |

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values except differential I/O bus voltages are with respect to network ground terminal and are peak voltage values.

## **RECOMMENDED OPERATING CONDITIONS**

|                                     |                                 | MIN  | TYP | MAX      | UNIT |
|-------------------------------------|---------------------------------|------|-----|----------|------|
| V <sub>CC1</sub> , V <sub>CC2</sub> | Supply voltage - 3.3V operation | 3.15 | 3.3 | 3.45     | V    |
|                                     | Supply voltage - 5V operation   | 4.75 | 5   | 5.25     | l    |
| I <sub>OH</sub>                     | High-level output current       | -4   |     |          | mA   |
| I <sub>OL</sub>                     | Low-level output current        |      |     | 4        | mA   |
| V <sub>IH</sub>                     | High-level input voltage        | 2    |     | $V_{CC}$ | V    |
| V <sub>IL</sub>                     | Low-level input voltage         | 0    |     | 0.8      | V    |
| T <sub>J</sub> <sup>(1)</sup>       | Junction temperature            | -40  |     | 136      | °C   |
| 1/t <sub>ui</sub>                   | Signaling rate                  | 0    |     | 1        | Mbps |
| t <sub>ui</sub>                     | Input pulse duration            | 1    |     |          | us   |

(1) To maintain the recommended operating conditions for T<sub>J</sub>, see the *Package Thermal Characteristics* table and the I<sub>CC</sub> limits in this data sheet.

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## **ELECTRICAL CHARACTERISTICS**

 $V_{CC1}$  and  $V_{CC2}$  at 5V ± 5%;  $T_A$  = –40°C to 125°C for ISO742xM,  $T_A$  = –40°C to 105°C for ISO742x

|                     | PARAMETER                           | TEST COND  | ITIONS                            | MIN                   | TYP | MAX | UNIT  |
|---------------------|-------------------------------------|--|-----------------------------------|-----------------------|-----|-----|-------|
| V                   |                                     | I <sub>OH</sub> = -4 mA; see Figure 1.   | V <sub>CC</sub> – 0.8             | 4.6                   |     | V   |       |
| V <sub>OH</sub>     | High-level output voltage           | $I_{OH} = -20 \ \mu A$ ; see Figure 1  |                                   | V <sub>CC</sub> – 0.1 | 5   |     | V     |
|                     |                                     | I <sub>OL</sub> = 4 mA; see Figure 1.  |                                   |                       | 0.2 | 0.4 |       |
| V <sub>OL</sub>     | Low-level output voltage            | $I_{OL} = 20 \ \mu A$ ; see Figure 1.  |                                   |                       | 0   | 0.1 | V     |
| V <sub>I(HYS)</sub> | Input threshold voltage hysteresis  |  |                                   |                       | 400 |     | mV    |
| I <sub>IH</sub>     | High-level input current            | INx at 0 V or $V_{CC}$<br>V <sub>I</sub> = V <sub>CC</sub> or 0 V; see Figure 3. |                                   |                       |     | 10  | μA    |
| IIL                 | Low-level input current             |  |                                   | -10                   |     |     | μA    |
| CMTI                | Common-mode transient immunity      |  |                                   | 25                    | 50  |     | kV/μs |
| SUPPL               | Y CURRENT (All inputs switching v   | ith square wave clock sig  | nal for dynamic ICC               | measurement)          |     |     |       |
|                     | ISO7420                             |  |                                   |                       |     |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> |  |                                   |                       | 0.4 | 1   |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 Mbps $V_1 = V_{CC}$ or   | 0 V, 15 pF load                   |                       | 3   | 6   | mA    |
|                     | ISO7421                             | L L  |                                   |                       |     |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> |  |                                   |                       | 2   | 4   |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 ivibps $V_{I} = V_{CC}$ or   | $V_I = V_{CC}$ or 0 V, 15 pF load |                       | 2   | 4   | mA    |

## SWITCHING CHARACTERISTICS

 $V_{CC1}$  and  $V_{CC2}$  at 5V  $\pm$  5%;  $T_A$  = –40°C to 125°C for ISO742xM,  $T_A$  = –40°C to 105°C for ISO742X

|                                     | PARAMETER   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|---|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay time                                      | See Figure 1.   |     | 9   | 14  | ns   |
| PWD <sup>(1)</sup>                  | Pulse width distortion  t <sub>PHL</sub> – t <sub>PLH</sub> |                 |     | 0.3 | 3.5 | ns   |
| t <sub>sk(pp)</sub>                 | Part-to-part skew time                                      |                 |     |     | 4   | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew time                         |                 |     |     | 3.6 | ns   |
| t <sub>r</sub>                      | Output signal rise time                                     | See Figure 1.   |     | 1   |     | ns   |
| t <sub>f</sub>                      | Output signal fall time                                     |                 |     | 1   |     | ns   |
| t <sub>fs</sub>                     | Fail-safe output delay time from input power loss           | See Figure 2.   |     | 6   |     | μs   |

(1) Also known as pulse skew.

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Product Folder Link(s): ISO7420 ISO7420M ISO7421 ISO7421M

ISO7420, ISO7420M ISO7421, ISO7421M

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### **ELECTRICAL CHARACTERISTICS**

 $V_{CC1}$  at 5V ± 5%,  $V_{CC2}$  at 3.3V ± 5%;  $T_A = -40^{\circ}$ C to 125°C for ISO742xM ,  $T_A = -40^{\circ}$ C to 105°C for ISO742x

|                     | PARAMETER                           | ТЕ                                    | EST CONDITIONS   | MIN                   | TYP             | MAX | UNIT  |
|---------------------|-------------------------------------|---------------------------------------|--|-----------------------|-----------------|-----|-------|
|                     |                                     | I <sub>OH</sub> = -4 mA;              | ISO7421 (5-V side)   | V <sub>CC</sub> - 0.8 | 4.6             |     |       |
| V <sub>OH</sub>     | High-level output voltage           | see Figure 1.                         | ISO7420 / 7421 (3.3-V side)                                  | $V_{CC} - 0.4$        | 3               |     | V     |
|                     |                                     | $I_{OH} = -20 \ \mu A;$               | see Figure 1,  | V <sub>CC</sub> – 0.1 | V <sub>CC</sub> |     |       |
| V                   |                                     | I <sub>OL</sub> = 4 mA; see Figure 1. |  |                       | 0.2             | 0.4 | V     |
| V <sub>OL</sub>     | Low-level output voltage            | $I_{OL} = 20 \ \mu A$ ; see Figure 1. |  |                       | 0               | 0.1 | v     |
| V <sub>I(HYS)</sub> | Input threshold voltage hysteresis  |                                       |  |                       | 400             |     | mV    |
| I <sub>IH</sub>     | High-level input current            | INty at 0.1/ at 1/                    |  |                       |                 | 10  | μA    |
| I <sub>IL</sub>     | Low-level input current             |                                       | INx at 0 V or V <sub>CC</sub>                                |                       |                 |     | μA    |
| CMTI                | Common-mode transient immunity      | $V_{I} = V_{CC} \text{ or } 0$        | /; see Figure 3.   | 25                    | 40              |     | kV/μs |
| SUPPLY              | CURRENT (All inputs switching with  | square wave clo                       | ck signal for dynamic ICC me                                 | asurement)            |                 |     |       |
| -                   | ISO7420                             |                                       |  |                       |                 |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> | DC to 1 Mhno                          | V/V/or0V/15 p5 lood  |                       | 0.4             | 1   | mA    |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> |                                       | $V_{I} = V_{CC} \text{ or } 0 \text{ V}, 15 \text{ pF load}$ |                       | 2               | 4.5 | mA    |
|                     | ISO7421                             |                                       |  |                       |                 |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> | DC to 1 Mhrs                          | V/V/or0V/15 p5 lood  |                       | 2               | 4   | mA    |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> |                                       | $V_{I} = V_{CC} \text{ or } 0 \text{ V}, 15 \text{ pF load}$ |                       | 1.5             | 3.5 | mA    |

### SWITCHING CHARACTERISTICS

 $V_{CC1}$  at 5V ± 5%,  $V_{CC2}$  at 3.3V ± 5%;  $T_A = -40^{\circ}$ C to 125°C for ISO742xM,  $T_A = -40^{\circ}$ C to 105°C for ISO742x

|                                     | PARAMETER   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|---|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay time                                      | See Figure 1.   |     | 10  | 17  | ns   |
| PWD <sup>(1)</sup>                  | Pulse width distortion  t <sub>PHL</sub> – t <sub>PLH</sub> |                 |     | 0.5 | 4   | ns   |
| t <sub>sk(pp)</sub>                 | Part-to-part skew time                                      |                 |     |     | 5   | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew time                         |                 |     |     | 4   | ns   |
| t <sub>r</sub>                      | Output signal rise time                                     | See Figure 1.   |     | 2   |     | ns   |
| t <sub>f</sub>                      | Output signal fall time                                     |                 |     | 2   |     | ns   |
| t <sub>fs</sub>                     | Fail-safe output delay time from input power loss           | See Figure 2.   |     | 6   |     | μs   |

(1) Also known as pulse skew.

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### **ELECTRICAL CHARACTERISTICS**

 $V_{CC1}$  at 3.3V ± 5%,  $V_{CC2}$  at 5V ± 5%;  $T_A = -40^{\circ}$ C to 125°C for ISO742xM,  $T_A = -40^{\circ}$ C to 105°C for ISO742X

|                     | PARAMETER                           | TE  | ST CONDITIONS  | MIN                   | TYP             | MAX | UNIT  |
|---------------------|-------------------------------------|---|--|-----------------------|-----------------|-----|-------|
|                     |                                     | I <sub>OH</sub> = −4 mA;<br>see Figure 1. |  | V <sub>CC</sub> – 0.8 | 4.6             |     |       |
| V <sub>OH</sub>     | High-level output voltage           |   | ISO7421 (3.3-V side)   | $V_{CC} - 0.4$        | 3               |     | V     |
|                     |                                     | I <sub>OH</sub> = -20 μA; s               | ee Figure 1  | V <sub>CC</sub> – 0.1 | V <sub>CC</sub> |     |       |
|                     |                                     | I <sub>OL</sub> = 4 mA; see Figure 1.     |  |                       | 0.2             | 0.4 | V     |
| V <sub>OL</sub>     | Low-level output voltage            | $I_{OL}$ = 20 µA; see Figure 1.           |  |                       | 0               | 0.1 | V     |
| V <sub>I(HYS)</sub> | Input threshold voltage hysteresis  |   |  |                       | 400             |     | mV    |
| I <sub>IH</sub>     | High-level input current            | — INx at 0 V or V <sub>CC</sub>           |  |                       |                 | 10  | μA    |
| IIL                 | Low-level input current             |   |  | -10                   |                 |     | μA    |
| CMTI                | Common-mode transient immunity      | $V_{I} = V_{CC} \text{ or } 0 V$          | ; see Figure 3.  | 25                    | 40              |     | kV/μs |
| SUPPLY              | CURRENT (All inputs switching with  | square wave cloc                          | k signal for dynamic ICC me                                  | asurement)            |                 |     |       |
|                     | ISO7420                             |   |  |                       |                 |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> |   |  |                       | 0.2             | 0.7 |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 Mbps                              | $V_{I} = V_{CC} \text{ or } 0 \text{ V}, 15 \text{ pF load}$ |                       | 3               | 6   | mA    |
|                     | ISO7421                             |   |  |                       |                 | 1   |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> |   |  |                       | 1.5             | 3.5 |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 Mbps                              | $V_{I} = V_{CC} \text{ or } 0 \text{ V}, 15 \text{ pF load}$ |                       | 2               | 4   | mA    |

### SWITCHING CHARACTERISTICS

 $V_{CC1}$  at 3.3V ± 5%,  $V_{CC2}$  at 5V ± 5%,  $T_A = -40^{\circ}$ C to 125°C for ISO742xM,  $T_A = -40^{\circ}$ C to 105°C for ISO742x

|                                     | PARAMETER   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|---|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay time                                      | See Figure 1.   |     | 10  | 17  | ns   |
| PWD <sup>(1)</sup>                  | Pulse width distortion  t <sub>PHL</sub> – t <sub>PLH</sub> |                 |     | 0.5 | 4   | ns   |
| t <sub>sk(pp)</sub>                 | Part-to-part skew time                                      |                 |     |     | 5   | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew time                         |                 |     |     | 4   | ns   |
| t <sub>r</sub>                      | Output signal rise time                                     | See Figure 1.   |     | 2   |     | ns   |
| t <sub>f</sub>                      | Output signal fall time                                     |                 |     | 2   |     | ns   |
| t <sub>fs</sub>                     | Fail-safe output delay time from input power loss           | See Figure 2.   |     | 6   |     | μs   |

(1) Also known as pulse skew.

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## **ELECTRICAL CHARACTERISTICS**

 $V_{CC1}$  and  $V_{CC2}$  at 3.3V  $\pm$  5%,  $T_A$  = –40°C to 125°C for ISO742xM,  $T_A$  = –40°C to 105°C for ISO742x

|                     | PARAMETER                           |                                      | TEST CONDITIONS  | MIN                   | TYP | MAX | UNIT  |
|---------------------|-------------------------------------|--------------------------------------|--|-----------------------|-----|-----|-------|
| N/                  |                                     | I <sub>OH</sub> = -4 mA; se          | V <sub>CC</sub> - 0.4  | 3                     |     | V   |       |
| V <sub>OH</sub>     | High-level output voltage           | I <sub>OH</sub> = -20 μA; s          | ee Figure 1.   | V <sub>CC</sub> – 0.1 | 3.3 |     | V     |
|                     |                                     | I <sub>OL</sub> = 4 mA; see          | Figure 1.  |                       | 0.2 | 0.4 |       |
| V <sub>OL</sub>     | Low-level output voltage            | I <sub>OL</sub> = 20 μA; see         | e Figure 1.  |                       | 0   | 0.1 | V     |
| V <sub>I(HYS)</sub> | Input threshold voltage hysteresis  |                                      |  |                       | 400 |     | mV    |
| I <sub>IH</sub>     | High-level input current            | INterna ( ) ( an ) (                 |  |                       |     | 10  | μΑ    |
| IIL                 | Low-level input current             | INx at 0 V or V <sub>C</sub>         | 00   | -10                   |     |     | μΑ    |
| CMTI                | Common-mode transient immunity      | $V_{I} = V_{CC} \text{ or } 0 V_{I}$ | ; see Figure 3.  | 25                    | 40  |     | kV/μs |
| SUPPL               | Y CURRENT (All inputs switching     | with square wa                       | ave clock signal for dynamic ICC                             | measurement)          |     | 1   |       |
|                     | ISO7420                             |                                      |  |                       |     |     |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> |                                      |  |                       | 0.2 | 0.7 |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 Mbps                         | $V_{I} = V_{CC} \text{ or } 0 \text{ V}, 15 \text{ pF load}$ |                       | 2   | 4.5 | mA    |
|                     | IS07421                             | 1                                    |  |                       |     | 1   |       |
| I <sub>CC1</sub>    | Supply current for V <sub>CC1</sub> | DC to 1 Mb                           |  |                       | 1.5 | 3.5 |       |
| I <sub>CC2</sub>    | Supply current for V <sub>CC2</sub> | DC to 1 Mbps                         | $V_I = V_{CC}$ or 0 V, 15 pF load                            |                       | 1.5 | 3.5 | mA    |

## SWITCHING CHARACTERISTICS

 $V_{CC1}$  and  $V_{CC2}$  at 3.3V ± 5%,  $T_A = -40^{\circ}$ C to 125°C for ISO742xM,  $T_A = -40^{\circ}$ C to 105°C for ISO742x

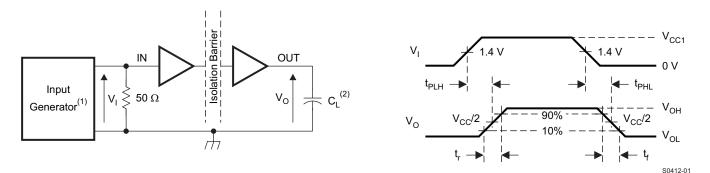
|                                     | PARAMETER   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|---|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay time                                      |                 |     | 12  | 20  | ns   |
| PWD <sup>(1)</sup>                  | Pulse width distortion  t <sub>PHL</sub> - t <sub>PLH</sub> | See Figure 1.   |     | 1   | 5   | ns   |
| t <sub>sk(pp)</sub>                 | Part-to-part skew time                                      |                 |     |     | 6   | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew time                         |                 |     |     | 5.5 | ns   |
| t <sub>r</sub>                      | Output signal rise time                                     | See Figure 1.   |     | 2   |     | ns   |
| t <sub>f</sub>                      | Output signal fall time                                     |                 |     | 2   |     | ns   |
| t <sub>fs</sub>                     | Fail-safe output delay time from input power loss           | See Figure 2.   |     | 6   |     | μS   |

(1) Also known as pulse skew.

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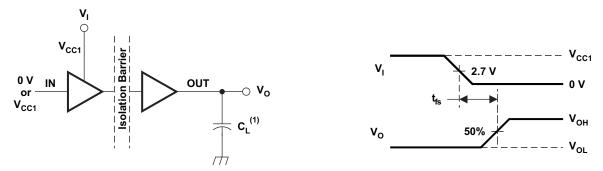
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#### PARAMETER MEASUREMENT INFORMATION



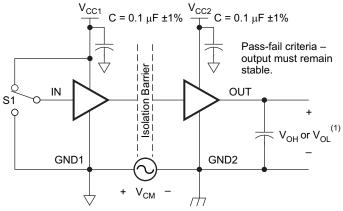
- (1) The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle,  $t_r \leq 3$  ns,  $t_f \leq 3$  ns,  $Z_O = 50 \Omega$ . At the input, a 50- $\Omega$  resistor is required to terminate the Input Generator signal. It is not needed in an actual application.
- (2)  $C_L = 15 \text{ pF} \pm 20\%$  includes instrumentation and fixture capacitance.

#### Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



(1)  $C_L = 15 \text{ pF} \pm 20\%$  includes instrumentation and fixture capacitance.

#### Figure 2. Fail-Safe Output Delay-Time Test Circuit and Voltage Waveforms



S0414-01

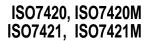
(1)  $C_L = 15 \text{ pF} \pm 20\%$  includes instrumentation and fixture capacitance.

### Figure 3. Common-Mode Transient Immunity Test Circuit

8

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Product Folder Link(s): ISO7420 ISO7420M ISO7421 ISO7421M



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### DEVICE INFORMATION

### **PACKAGE CHARACTERISTICS**

**STRUMENTS** 

over recommended operating conditions (unless otherwise noted)

|                 | PARAMETER   | TEST CONDITIONS  | MIN   | TYP               | MAX | UNIT |
|-----------------|---|--|-------|-------------------|-----|------|
| L(I01)          | Minimum air gap (clearance)                         | Shortest terminal-to-terminal distance through air                             | 4.8   |                   |     | mm   |
| L(102)          | Minimum external tracking<br>(creepage)             | Shortest terminal-to-terminal distance across the package surface              | 4.3   |                   |     | mm   |
| CTI             | Tracking resistance (comparative tracking index)    | DIN IEC 60112 / VDE 0303 Part 1  | >175  |                   |     | V    |
|                 | Minimum internal gap (internal clearance)           | Distance through the insulation  | 0.014 |                   |     | mm   |
| <u> </u>        | Isolation resistance, input to                      | V <sub>IO</sub> = 500 V, T <sub>A</sub> < 100°C                                |       | >10 <sup>12</sup> |     | Ω    |
| R <sub>IO</sub> | output <sup>(1)</sup>                               | $V_{IO} = 500 \text{ V}, 100^{\circ}\text{C} \le \text{T}_{A} \le \text{max}$  |       | >10 <sup>11</sup> |     | Ω    |
| C <sub>IO</sub> | Barrier capacitance, input to output <sup>(1)</sup> | $V_{IO} = 0.4 \sin (2\pi ft), f = 1 MHz$                                       |       | 1                 |     | pF   |
| CI              | Input capacitance <sup>(2)</sup>                    | $V_1 = V_{CC}/2 + 0.4 \sin (2\pi ft), f = 1 \text{ MHz}, V_{CC} = 5 \text{ V}$ |       | 1                 |     | pF   |

(1) All pins on each side of the barrier tied together creating a two-terminal device.

(2) Measured from input pin to ground.

#### NOTE

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance.

Creepage and clearance on a printed-circuit board become equal according to the measurement techniques shown in the Isolation Glossary. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

#### INSULATION CHARACTERISTICS<sup>(3)</sup>

over recommended operating conditions (unless otherwise noted)

|                   | PARAMETER                          | TEST CONDITIONS                                   | SPECIFICATION    | UNIT     |
|-------------------|------------------------------------|---|------------------|----------|
| VIORM             | Maximum working insulation voltage |   | 560              | Vpeak    |
| V <sub>PR</sub>   | Input-to-output test voltage       | t = 1 s (100% production), partial discharge 5 pC | 1050             | Vpeak    |
| V                 | Transient overvoltage              | t = 60 s (qualification)                          | 4000             | Vacak    |
| V <sub>IOTM</sub> |                                    | t = 1 s (100% production)                         | 4000             | Vpeak    |
| V                 | Isolation voltage per UL           | t = 60 s (qualification)                          | 2500             | ) (man a |
| VISO              |                                    | t = 1 s (100% production)                         | 3000             | Vrms     |
| R <sub>S</sub>    | Insulation resistance              | $V_{IO} = 500 \text{ V at } T_{S}$                | >10 <sup>9</sup> | Ω        |
|                   | Pollution degree                   |   | 2                |          |

(3) Climatic Classification 40/125/21

### Table 2. IEC 60664-1 RATINGS TABLE

| PARAMETER                  | TEST CONDITIONS                | SPECIFICATION |
|----------------------------|--------------------------------|---------------|
| Basic isolation group      | Material group                 | III-a         |
|                            | Rated mains voltage ≤ 150 Vrms | I–IV          |
| nstallation classification | Rated mains voltage ≤ 300 Vrms | I–III         |
|                            | Rated mains voltage ≤ 400 Vrms | I—II          |



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### **REGULATORY INFORMATION**

| VDE                                  | CSA   | UL   |
|--------------------------------------|---|--|
| Certified according to IEC 60747-5-2 | Approved under CSA Component<br>Acceptance Notice | Recognized under 1577 Component Recognition Program <sup>(1)</sup> |
| File number: pending (40016131)      | File number: pending (1698195)                    | File number: pending (E181974)                                     |

(1) Production tested  $\geq$  3000 Vrms for 1 second in accordance with UL 1577.

## LIFE EXPECTANCY vs WORKING VOLTAGE

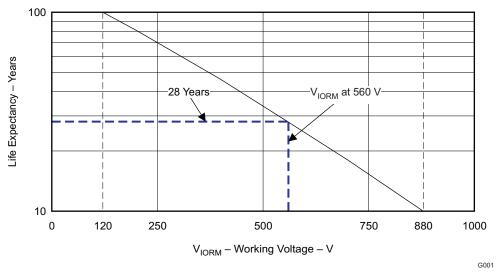


Figure 4. Life Expectancy vs Working Voltage

## IEC SAFETY LIMITING VALUES

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the I/O can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier, potentially leading to secondary system failures.

|                | PARAMETER                       | TEST CONDITIONS   | MIN | TYP | MAX | UNIT |
|----------------|---------------------------------|---|-----|-----|-----|------|
| I <sub>S</sub> | Safety input, output, or supply | $\theta_{JA} = 212^{\circ}C/W, V_{I} = 5.25 V, T_{J} = 150^{\circ}C, T_{A} = 25^{\circ}C$ |     |     | 112 | ~ ^  |
|                | current                         | $\theta_{JA} = 212^{\circ}C/W, V_{I} = 3.45 V, T_{J} = 150^{\circ}C, T_{A} = 25^{\circ}C$ |     |     | 171 | mA   |
| Τ <sub>S</sub> | Maximum case temperature        |   |     |     | 150 | °C   |

The safety-limiting constraint is the absolute-maximum junction temperature specified in the *Absolute Maximum Ratings* table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the *Thermal Characteristics* table is that of a device installed in the JESD51-3, Low-Effective-Thermal-Conductivity Test Board for Leaded Surface-Mount Packages and is conservative. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.



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## PACKAGE THERMAL CHARACTERISTICS

(over recommended operating conditions unless otherwise noted)

|                      | PARAMETER                            | TEST CONDITIONS   | MIN | TYP  | MAX | UNIT |
|----------------------|--------------------------------------|---|-----|------|-----|------|
| $\theta_{JA}$        | hunding to sight provide a sister of | Low-K thermal resistance <sup>(1)</sup>   |     | 212  |     | °C/W |
|                      | Junction-to-air thermal resistance   | High-K thermal resistance <sup>(1)</sup>  |     | 122  |     |      |
| $\theta_{JB}$        | Junction-to-board thermal resistance |   |     | 37   |     | °C/W |
| $\theta_{\text{JC}}$ | Junction-to-case thermal resistance  |   |     | 69.1 |     | °C/W |
| P <sub>D</sub>       | Device power dissipation             | $V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF},$<br>Input a 150-Mbps 50% duty-cycle square wave |     |      | 390 | mW   |

(1) Tested in accordance with the low-K or high-K thermal metric definitions of EIA/JESD51-3 for leaded surface-mount packages

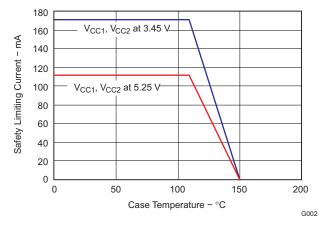


Figure 5.  $\theta_{JC}$  Thermal Derating Curve per IEC 60747-5-2

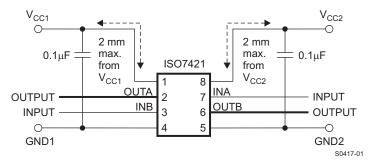


Figure 6. Typical ISO7421 Application Circuit



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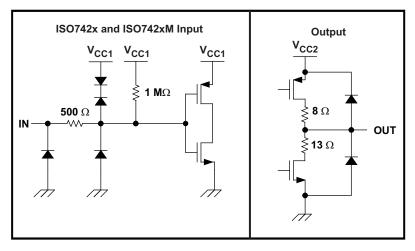
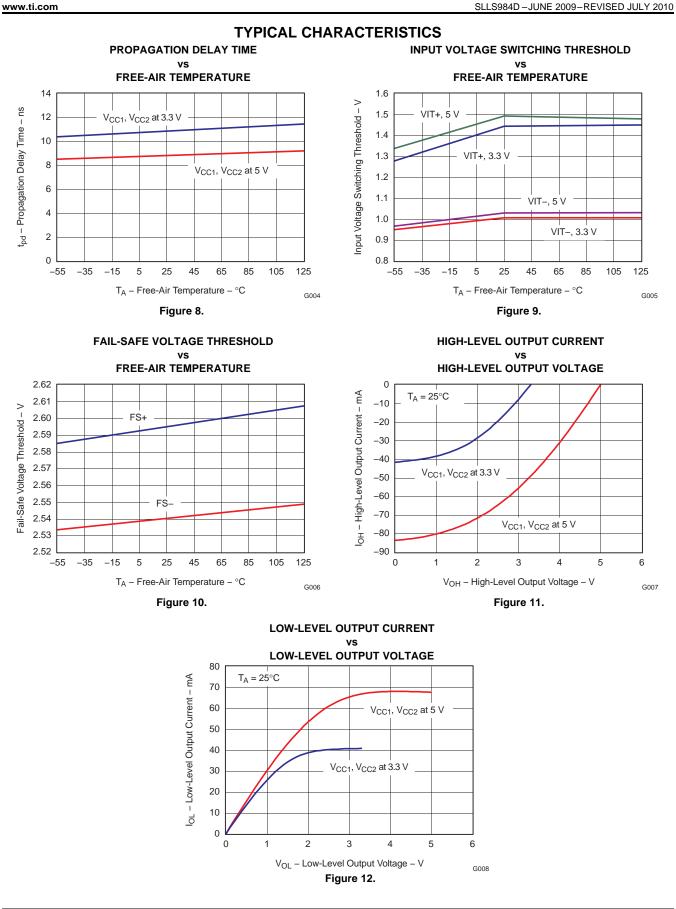


Figure 7. Device I/O Schematics



## ISO7420, ISO7420M ISO7421, ISO7421M

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Product Folder Link(s): /SO7420 /SO7420M /SO7421 /SO7421M

## ISO7420, ISO7420M ISO7421, ISO7421M

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## **REVISION HISTORY**

### Changes from Original (June 2009) to Revision A

| • | Added devices ISO7420 and ISO7420M to the data sheet 1 |
|---|--|
| • | Added the I <sub>CC</sub> EQUATIONS section            |

#### Changes from Revision A (December 2009) to Revision B

| ٠ | Switching Characteristics Table, Added Note (2) - Typical specifications are measured at ideal conditions of 25°C. |
|---|--|
|   | Max or Min specifications are measured at worst case conditions for $V_{CC}$ and temperature                       |

### Changes from Revision B (February 2010) to Revision C

| • | Added devices ISO7420F and ISO7420FM to the data sheet  | 1 |
|---|---|---|
| • | Added The suffix M indicates wide temperature range (-55°C to 125°C) and the suffix F indicates output-low option in fail-safe condition. All other devices without the F suffix default to output-high in fail-safe state. | 1 |
| • | Changed the Function Table Output values for PU (Open) From: H To: H/L  | 2 |
| • | Changed the Function Table Output values for PU (X) From: H To: H/L   | 2 |
| • | Changed the Function Table Output values for PU (X) From: H/L To: H   | 2 |
| • | Added Note (2) in the Function Table  | 2 |
| • | Added ISO7420F and ISO7420FM to the Available Options Table   | 2 |
| • | Changed value from a max of 4 mA to a min of -4 mA  | 3 |
| • | Changed value from a min of -4 mA to a max of 4 mA  | 3 |
| • | Changed Electrical Characteristics Conditions   | 4 |
| • | Deleted C <sub>i</sub> from the ELECTRICAL CHARACTERISTICS  | 4 |
| • | Added (All inputs switching with square wave clock signal for dynamic ICC measurement)  | 4 |
| • | Changed SWITCHING CHARACTERISTICS conditions  | 4 |
| • | Changed PWD parameter from duration to width  | 4 |
| • | Changed ELECTRICAL CHARACTERISTICS conditions   | 5 |
| • | Added High-level output voltage ISO7420 / 7421 (3.3-V side) test condition  | 5 |
| • | Changed High-level output voltage min value   | 5 |
| • | Deleted C <sub>1</sub> specification  | 5 |
| • | Added (All inputs switching with square wave clock signal for dynamic ICC measurement)  | 5 |
| • | Changed SWITCHING CHARACTERISTICS conditions  | 5 |
| • | Changed Pulse duration distortion to Pulse width distortion   | 5 |
| • | Changed ELECTRICAL CHARACTERISTICS conditions   | 6 |
| • | Added High-level output voltage ISO7420 / 7421 (5-V side) test condition  | 6 |
| • | Changed High-level output voltage min value   | 6 |
| • | Deleted C <sub>I</sub> specification  | 6 |
| • | Added (All inputs switching with square wave clock signal for dynamic ICC measurement)  | 6 |
| • | Changed SWITCHING CHARACTERISTICS conditions  | 6 |
| • | Changed Pulse duration distortion to Pulse width distortion   | 6 |
| • | Changed ELECTRICAL CHARACTERISTICS conditions   | 7 |
| • | Deleted C <sub>I</sub> specification  | 7 |
| • | Added (All inputs switching with square wave clock signal for dynamic ICC measurement)  | 7 |
| • | Changed SWITCHING CHARACTERISTICS conditions  | 7 |
| • | Changed Pulse duration distortion to Pulse width distortion   | 7 |
| • | Changed Note 1 Figure 1   | 8 |
| _ |   |   |



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#### SLLS984D-JUNE 2009-REVISED JULY 2010

| • | Changed Figure 2  | . 8 |
|---|---|-----|
| • | Added input to output and note 1 to Isolation resistance, input to output | . 9 |
| • | Changed the Isolation resistance test conditions                          | . 9 |
| • | Changed the Isolation resistance test conditions                          | . 9 |
| • | Added note 1 to Barrier capacitance, input to output                      | . 9 |
| • | Added Input capacitance   | . 9 |
| • | Changed $T_J = 170^{\circ}C$ to $T_J = 150^{\circ}C$                      | 10  |
| • | Changed From: 124mA To: 107mA   | 10  |
| • | Changed $T_J = 170^{\circ}C$ to $T_J = 150^{\circ}C$                      | 10  |
| • | Changed From: 190mA To: 164mA   | 10  |
|   | Changed Figure 5  |     |
| • | Changed Figure 7  | 12  |
|   |   |     |

### Changes from Revision C (March 2010) to Revision D

#### Page

| • | Deleted devices ISO7420F and ISO7420FM from the data sheet  | 1  |
|---|---|----|
| • | Updated the Features List   | 1  |
| • | Updated the device Description. Add paragraph - Note: The ISO7420 and ISO7421                         | 1  |
| • | Changed the Function Table Output values for PU (Open) From: H/L To: H                                | 2  |
| • | Changed ISO7420M T <sub>A</sub> temp From: -55 to 125 To: 40 to 125 in the Available Options Table    | 2  |
| • | Added Tstg to the Absolute Maximum Ratings Table  | 3  |
| • | Updated the Recommended Opetating Conditions Table  | 3  |
| • | Updates throughout the Electrical Characteristics and Switching Characteristics tables                | 4  |
| • | Updated the Supply Current test conditions  | 4  |
| • | Changed Figure 2  | 8  |
| • | Changed Note 1 in Figure 3  | 8  |
| • | Changed Minimum internal gap MIN value From: 0.008 To: 0.014mm  | 9  |
| • | Changed the Barrier capacitance, input to output test conditions                                      | 9  |
| • | Changed the Input capacitance test conditions   | 9  |
| • | Changed the V <sub>IORM</sub> , V <sub>PR</sub> , and V <sub>IOTM</sub> unit values From: V To: Vpeak | 9  |
| • | Changed V <sub>I</sub> From: 5.5V To: 5.25V   | 10 |
| • | Changed From: 107mA To: 112mA   | 10 |
| • | Changed V <sub>I</sub> From: 3.6V To: 3.45V   | 10 |
| • | Changed From: 164mA To: 171mA   | 10 |
| • | Changed Figure 5  | 11 |
| • | Deleted the I <sub>CC</sub> EQUATIONS section   | 11 |
| • | Changed Figure 7  | 12 |
| • | Deleted the SUPPLY CURRENT vs SIGNAL RATE (ALL CHANNELS) graphs and the EYE DIAGRAM plots             | 13 |

#### PACKAGING INFORMATION

RUMENTS

| Orderable Device | Status <sup>(1)</sup> | Package<br>Type | Package<br>Drawing | Pins | Package<br>Qty | e Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| ISO7420D         | ACTIVE                | SOIC            | D                  | 8    | 75             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7420DR        | ACTIVE                | SOIC            | D                  | 8    | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7420MD        | ACTIVE                | SOIC            | D                  | 8    | 75             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7420MDR       | ACTIVE                | SOIC            | D                  | 8    | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7421D         | ACTIVE                | SOIC            | D                  | 8    | 75             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7421DR        | ACTIVE                | SOIC            | D                  | 8    | 2500           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-1-260C-UNLIM           |
| ISO7421MD        | PREVIEW               | SOIC            | D                  | 8    | 75             | TBD                       | Call TI          | Call TI                      |
| ISO7421MDR       | PREVIEW               | SOIC            | D                  | 8    | 2500           | TBD                       | Call TI          | Call TI                      |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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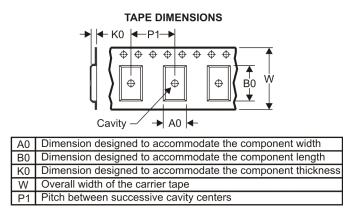
# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal |                 |                    |   |      |                          |                          |            |            |            |            |           |                  |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device                      | Package<br>Type | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| ISO7420DR                   | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| ISO7420MDR                  | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| ISO7421DR                   | SOIC            | D                  | 8 | 2500 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |

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# PACKAGE MATERIALS INFORMATION

20-Jul-2010

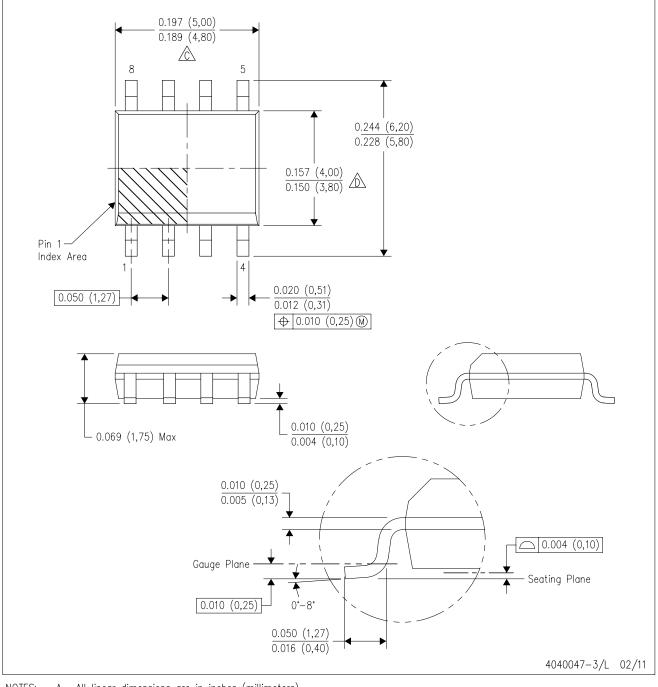


\*All dimensions are nominal

| Device     | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ISO7420DR  | SOIC         | D               | 8    | 2500 | 358.0       | 335.0      | 35.0        |
| ISO7420MDR | SOIC         | D               | 8    | 2500 | 358.0       | 335.0      | 35.0        |
| ISO7421DR  | SOIC         | D               | 8    | 2500 | 358.0       | 335.0      | 35.0        |

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE

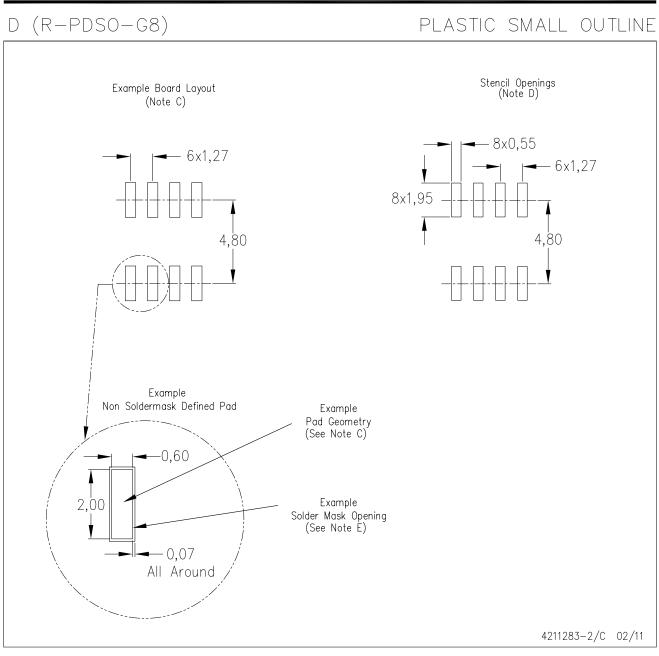


NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



## LAND PATTERN DATA



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
   E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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